

<b>Notice of References Cited</b>	Application/Control No. 10/588,622		Applicant(s)/Patent Under Reexamination SONNENSCHN ET AL.	
	Examiner XIAO ZHAO		Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0033227	03-2002	Sonnenschein et al.	156/306.9
*	B	US-2004/0259990	12-2004	Sonnenschein et al.	524/236
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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